### STMicroelectronics - STM32F407VGT7TR Datasheet



#### Welcome to E-XFL.COM

#### What is "Embedded - Microcontrollers"?

"Embedded - Microcontrollers" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

#### Applications of "<u>Embedded -</u> <u>Microcontrollers</u>"

#### Details

E·XFI

Product Status	Active
Core Processor	ARM® Cortex®-M4
Core Size	32-Bit Single-Core
Speed	168MHz
Connectivity	CANbus, DCMI, EBI/EMI, Ethernet, I <sup>2</sup> C, IrDA, LINbus, SPI, UART/USART, USB OTG
Peripherals	Brown-out Detect/Reset, DMA, I <sup>2</sup> S, LCD, POR, PWM, WDT
Number of I/O	82
Program Memory Size	1MB (1M × 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	192K x 8
Voltage - Supply (Vcc/Vdd)	1.8V ~ 3.6V
Data Converters	A/D 16x12b; D/A 2x12b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 105°C (TA)
Mounting Type	Surface Mount
Package / Case	100-LQFP
Supplier Device Package	100-LQFP (14x14)
Purchase URL	https://www.e-xfl.com/product-detail/stmicroelectronics/stm32f407vgt7tr

Email: info@E-XFL.COM

Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong

Figure 40.	SPI timing diagram - slave mode and CPHA = 1	124
Figure 41.	SPI timing diagram - master mode	125
Figure 42.	I2S slave timing diagram (Philips protocol)	127
Figure 43.	I2S master timing diagram (Philips protocol) <sup>(1)</sup>	127
Figure 44.	USB OTG FS timings: definition of data signal rise and fall time	129
Figure 45.	ULPI timing diagram.	130
Figure 46.	Ethernet SMI timing diagram	131
Figure 47.	Ethernet RMII timing diagram	132
Figure 48	Ethernet MII timing diagram	132
Figure 49	ADC accuracy characteristics	136
Figure 50	Typical connection diagram using the ADC	136
Figure 51	Power supply and reference decoupling (V not connected to V)	137
Figure 51.	Tower supply and reference decoupling ( $V_{REF+}$ not connected to $V_{DDA}$ )	120
Figure 52.	Power supply and reference decoupling (V <sub>REF+</sub> connected to V <sub>DDA</sub> )	130
Figure 53.		142
Figure 54.	Asynchronous non-multiplexed SRAM/PSRAM/NOR read waveforms	143
Figure 55.	Asynchronous non-multiplexed SRAM/PSRAM/NOR write waveforms	144
Figure 56.	Asynchronous multiplexed PSRAM/NOR read waveforms.	145
Figure 57.	Asynchronous multiplexed PSRAM/NOR write waveforms	146
Figure 58.	Synchronous multiplexed NOR/PSRAM read timings	147
Figure 59.	Synchronous multiplexed PSRAM write timings	149
Figure 60.	Synchronous non-multiplexed NOR/PSRAM read timings	150
Figure 61.	Synchronous non-multiplexed PSRAM write timings	152
Figure 62.	PC Card/CompactFlash controller waveforms for common memory read access	153
Figure 63.	PC Card/CompactFlash controller waveforms for common memory write access	154
Figure 64.	PC Card/CompactFlash controller waveforms for attribute memory read	
0	access	155
Figure 65.	PC Card/CompactElash controller waveforms for attribute memory write	
	access	156
Figure 66	PC Card/CompactElash controller waveforms for I/O space read access	156
Figure 67	PC Card/CompactFlash controller waveforms for I/O space write access	157
Figure 68	NAND controller waveforms for read access	150
Figure 60.	NAND controller waveforms for write access	150
Figure 70	NAND controller waveforms for common momenty read access	160
Figure 70.	NAND controller waveforms for common memory write access	160
Figure 71.		100
Figure 72.		101
Figure 73.		162
Figure 74.	SD default mode	163
Figure 75.	WLCSP90 - 4.223 x 3.969 mm, 0.400 mm pitch water level chip scale	
	package outline	164
Figure 76.	WLCSP90 - 4.223 x 3.969 mm, 0.400 mm pitch wafer level chip scale	
	recommended footprint	165
Figure 77.	WLCSP90 marking example (package top view)	166
Figure 78.	LQFP64 – 64-pin, 10 x 10 mm low-profile quad flat package outline	167
Figure 79.	LQFP64 – 64-pin, 10 x 10 mm low-profile quad flat package	
	recommended footprint	168
Figure 80.	LPQF64 marking example (package top view)	169
Figure 81.	LQFP100 - 100-pin, 14 x 14 mm low-profile guad flat package outline	170
Figure 82	LQFP100 - 100-pin, 14 x 14 mm low-profile guad flat	-
J	recommended footprint.	171
Figure 83	I QEP100 marking example (package top view)	172
Figure 84	I QEP144 - 144-pin 20 x 20 mm low-profile guad flat package outline	173
Figure 85	I OEP144 - 144-pin 20 x 20 mm low-profile quad flat package	
. iguic 00.	Estimate provide the provide t	



# 1 Introduction

This datasheet provides the description of the STM32F405xx and STM32F407xx lines of microcontrollers. For more details on the whole STMicroelectronics STM32<sup>™</sup> family, please refer to Section 2.1: Full compatibility throughout the family.

The STM32F405xx and STM32F407xx datasheet should be read in conjunction with the STM32F4xx reference manual which is available from the STMicroelectronics website *www.st.com*.

For information on the Cortex<sup>®</sup>-M4 core, please refer to the Cortex<sup>®</sup>-M4 programming manual (PM0214) available from *www.st.com*.





Figure 4. Compatible board design between STM32F2 and STM32F40xxx for LQFP176 and BGA176 packages



# 2.2 Device overview



Figure 5. STM32F40xxx block diagram

1. The camera interface and ethernet are available only on STM32F407xx devices.



# 2.2.26 Audio PLL (PLLI2S)

The devices feature an additional dedicated PLL for audio I<sup>2</sup>S application. It allows to achieve error-free I<sup>2</sup>S sampling clock accuracy without compromising on the CPU performance, while using USB peripherals.

The PLLI2S configuration can be modified to manage an  $I^2S$  sample rate change without disabling the main PLL (PLL) used for CPU, USB and Ethernet interfaces.

The audio PLL can be programmed with very low error to obtain sampling rates ranging from 8 KHz to 192 KHz.

In addition to the audio PLL, a master clock input pin can be used to synchronize the  $I^2S$  flow with an external PLL (or Codec output).

# 2.2.27 Secure digital input/output interface (SDIO)

An SD/SDIO/MMC host interface is available, that supports MultiMediaCard System Specification Version 4.2 in three different databus modes: 1-bit (default), 4-bit and 8-bit.

The interface allows data transfer at up to 48 MHz, and is compliant with the SD Memory Card Specification Version 2.0.

The SDIO Card Specification Version 2.0 is also supported with two different databus modes: 1-bit (default) and 4-bit.

The current version supports only one SD/SDIO/MMC4.2 card at any one time and a stack of MMC4.1 or previous.

In addition to SD/SDIO/MMC, this interface is fully compliant with the CE-ATA digital protocol Rev1.1.

## 2.2.28 Ethernet MAC interface with dedicated DMA and IEEE 1588 support

Peripheral available only on the STM32F407xx devices.

The STM32F407xx devices provide an IEEE-802.3-2002-compliant media access controller (MAC) for ethernet LAN communications through an industry-standard mediumindependent interface (MII) or a reduced medium-independent interface (RMII). The STM32F407xx requires an external physical interface device (PHY) to connect to the physical LAN bus (twisted-pair, fiber, etc.). the PHY is connected to the STM32F407xx MII port using 17 signals for MII or 9 signals for RMII, and can be clocked using the 25 MHz (MII) from the STM32F407xx.



alternate functions. All GPIOs are high-current-capable and have speed selection to better manage internal noise, power consumption and electromagnetic emission.

The I/O configuration can be locked if needed by following a specific sequence in order to avoid spurious writing to the I/Os registers.

Fast I/O handling allowing maximum I/O toggling up to 84 MHz.

### 2.2.35 Analog-to-digital converters (ADCs)

Three 12-bit analog-to-digital converters are embedded and each ADC shares up to 16 external channels, performing conversions in the single-shot or scan mode. In scan mode, automatic conversion is performed on a selected group of analog inputs.

Additional logic functions embedded in the ADC interface allow:

- Simultaneous sample and hold
- Interleaved sample and hold

The ADC can be served by the DMA controller. An analog watchdog feature allows very precise monitoring of the converted voltage of one, some or all selected channels. An interrupt is generated when the converted voltage is outside the programmed thresholds.

To synchronize A/D conversion and timers, the ADCs could be triggered by any of TIM1, TIM2, TIM3, TIM4, TIM5, or TIM8 timer.

### 2.2.36 Temperature sensor

The temperature sensor has to generate a voltage that varies linearly with temperature. The conversion range is between 1.8 V and 3.6 V. The temperature sensor is internally connected to the ADC1\_IN16 input channel which is used to convert the sensor output voltage into a digital value.

As the offset of the temperature sensor varies from chip to chip due to process variation, the internal temperature sensor is mainly suitable for applications that detect temperature changes instead of absolute temperatures. If an accurate temperature reading is needed, then an external temperature sensor part should be used.

# 2.2.37 Digital-to-analog converter (DAC)

The two 12-bit buffered DAC channels can be used to convert two digital signals into two analog voltage signal outputs.

This dual digital Interface supports the following features:

- two DAC converters: one for each output channel
- 8-bit or 12-bit monotonic output
- left or right data alignment in 12-bit mode
- synchronized update capability
- noise-wave generation
- triangular-wave generation
- dual DAC channel independent or simultaneous conversions
- DMA capability for each channel
- external triggers for conversion
- input voltage reference V<sub>REF+</sub>



DocID022152 Rev 8

		AF0	AF1	AF2	AF3	AF4	AF5	AF6	AF7	AF8	AF9	AF10	AF11	AF12	AF13		
Po	ort	SYS	TIM1/2	TIM3/4/5	TIM8/9/10 /11	I2C1/2/3	SPI1/SPI2/ I2S2/I2S2e xt	SPI3/I2Sext /I2S3	USART1/2/3/ I2S3ext	UART4/5/ USART6	CAN1/2 TIM12/13/ 14	OTG_FS/ OTG_HS	ЕТН	FSMC/SDIO /OTG_FS	DCMI	AF14	AF15
	PE0	-	-	TIM4_ETR	-	-	-	-	-	-	-	-	-	FSMC_NBL0	DCMI_D2	-	EVENTOUT
	PE1	-	-	-	-	-	-	-	-	-	-	-	-	FSMC_NBL1	DCMI_D3	-	EVENTOUT
	PE2	TRACECL K	-	-	-	-	-	-	-	-	-	-	ETH_MII_TXD3	FSMC_A23	-	-	EVENTOUT
	PE3	TRACED0	-	-	-	-	-	-	-	-	-	-	-	FSMC_A19	-	-	EVENTOUT
PE4	PE4	TRACED1	-	-	-	-	-	-	-	-	-	-	-	FSMC_A20	DCMI_D4	-	EVENTOUT
	PE5	TRACED2	-	-	TIM9_CH1	-	-	-	-	-	-	-	-	FSMC_A21	DCMI_D6	-	EVENTOUT
	PE6	TRACED3	-	-	TIM9_CH2	-	-	-	-	-	-	-	-	FSMC_A22	DCMI_D7	-	EVENTOUT
Port E	PE7	-	TIM1_ETR	-	-	-	-	-	-	-	-	-	-	FSMC_D4	-	-	EVENTOUT
	PE8	-	TIM1_CH1N	-	-	-	-	-	-	-	-	-	-	FSMC_D5	-	-	EVENTOUT
	PE9	-	TIM1_CH1	-	-	-	-	-	-	-	-	-	-	FSMC_D6	-	-	EVENTOUT
	PE10	-	TIM1_CH2N	-	-	-	-	-	-	-	-	-	-	FSMC_D7	-	-	EVENTOUT
	PE11	-	TIM1_CH2	-	-	-	-	-	-	-	-	-	-	FSMC_D8	-	-	EVENTOUT
	PE12	-	TIM1_CH3N	-	-	-	-	-	-	-	-	-	-	FSMC_D9	-	-	EVENTOUT
	PE13	-	TIM1_CH3	-	-	-	-	-	-	-	-	-	-	FSMC_D10	-	-	EVENTOUT
	PE14	-	TIM1_CH4	-	-	-	-	-	-	-	-	-	-	FSMC_D11	-	-	EVENTOUT
	PE15	-	TIM1_BKIN	-	-	-	-	-	-	-	-	-	-	FSMC_D12	-	-	EVENTOUT

 Table 9. Alternate function mapping (continued)

		AF0	AF1	AF2	AF3	AF4	AF5	AF6	AF7	AF8	AF9	AF10	AF11	AF12	AF13		
Ρ	ort	SYS	TIM1/2	TIM3/4/5	TIM8/9/10 /11	I2C1/2/3	SPI1/SPI2/ I2S2/I2S2e xt	SPI3/I2Sext /I2S3	USART1/2/3/ I2S3ext	UART4/5/ USART6	CAN1/2 TIM12/13/ 14	OTG_FS/ OTG_HS	ЕТН	FSMC/SDIO /OTG_FS	DCMI	AF14	AF15
	PG0	-	-	-	-	-	-	-	-	-	-	-	-	FSMC_A10	-	-	EVENTOUT
	PG1	-	-	-	-	-	-	-	-	-	-	-	-	FSMC_A11	-	-	EVENTOUT
	PG2	-	-	-	-	-	-	-	-	-	-	-	-	FSMC_A12	-	-	EVENTOUT
	PG3	-	-	-	-	-	-	-	-	-	-	-	-	FSMC_A13	-	-	EVENTOUT
	PG4	-	-	-	-	-	-	-	-	-	-	-	-	FSMC_A14	-	-	EVENTOUT
	PG5	-	-	-	-	-	-	-	-	-	-	-	-	FSMC_A15	-	-	EVENTOUT
	PG6	-	-	-	-	-	-	-	-	-	-	-	-	FSMC_INT2	-	-	EVENTOUT
	PG7	-	-	-	-	-	-	-	-	USART6_CK	-	-	-	FSMC_INT3	-	-	EVENTOUT
	PG8	-	-	-	-	-	-	-	-	USART6_ RTS	-	-	ETH_PPS_OUT	-	-	-	EVENTOUT
Port G	PG9	-	-	-	-	-	-	-	-	USART6_RX	-	-	-	FSMC_NE2/ FSMC_NCE3	-	-	EVENTOUT
	PG10	-	-	-	-	-	-	-	-	-	-	-	-	FSMC_ NCE4_1/ FSMC_NE3	-	-	EVENTOUT
	PG11	-	-	-	-	-	-	-	-	-	-	-	ETH _MII_TX_EN ETH _RMII_ TX_EN	FSMC_NCE4_ 2	-	-	EVENTOUT
	PG12	-	-	-	-	-	-	-	-	USART6_ RTS	-	-	-	FSMC_NE4	-	-	EVENTOUT
	PG13	-	-	-	-	-	-	-	-	UART6_CTS	-	-	ETH _MII_TXD0 ETH _RMII_TXD0	FSMC_A24	-	-	EVENTOUT
	PG14	-	-	-	-	-	-	-	-	USART6_TX	-	-	ETH _MII_TXD1 ETH _RMII_TXD1	FSMC_A25	-	-	EVENTOUT
	PG15	-	-	-	-	-	-	-	-	USART6_ CTS	-	-	-	-	DCMI_D13	-	EVENTOUT

#### Table 9. Alternate function mapping (continued)

DocID022152 Rev 8

57

68/202

STM32F405xx, STM32F407xx

Pinouts and pin description

Bus	Boundary address	Peripheral
	0x4001 4C00 - 0x4001 57FF	Reserved
	0x4001 4800 - 0x4001 4BFF	TIM11
	0x4001 4400 - 0x4001 47FF	TIM10
	0x4001 4000 - 0x4001 43FF	ТІМ9
	0x4001 3C00 - 0x4001 3FFF	EXTI
	0x4001 3800 - 0x4001 3BFF	SYSCFG
	0x4001 3400 - 0x4001 37FF	Reserved
	0x4001 3000 - 0x4001 33FF	SPI1
APB2	0x4001 2C00 - 0x4001 2FFF	SDIO
	0x4001 2400 - 0x4001 2BFF	Reserved
	0x4001 2000 - 0x4001 23FF	ADC1 - ADC2 - ADC3
	0x4001 1800 - 0x4001 1FFF	Reserved
	0x4001 1400 - 0x4001 17FF	USART6
	0x4001 1000 - 0x4001 13FF	USART1
	0x4001 0800 - 0x4001 0FFF	Reserved
	0x4001 0400 - 0x4001 07FF	ТІМ8
	0x4001 0000 - 0x4001 03FF	TIM1
	0x4000 7800- 0x4000 FFFF	Reserved

Table 10. register boundary addresses (continued)



Bus	Boundary address	Peripheral
	0x4000 7800 - 0x4000 7FFF	Reserved
	0x4000 7400 - 0x4000 77FF	DAC
	0x4000 7000 - 0x4000 73FF	PWR
	0x4000 6C00 - 0x4000 6FFF	Reserved
	0x4000 6800 - 0x4000 6BFF	CAN2
	0x4000 6400 - 0x4000 67FF	CAN1
	0x4000 6000 - 0x4000 63FF	Reserved
	0x4000 5C00 - 0x4000 5FFF	I2C3
	0x4000 5800 - 0x4000 5BFF	I2C2
	0x4000 5400 - 0x4000 57FF	I2C1
	0x4000 5000 - 0x4000 53FF	UART5
	0x4000 4C00 - 0x4000 4FFF	UART4
	0x4000 4800 - 0x4000 4BFF	USART3
	0x4000 4400 - 0x4000 47FF	USART2
	0x4000 4000 - 0x4000 43FF	I2S3ext
APB1	0x4000 3C00 - 0x4000 3FFF	SPI3 / I2S3
	0x4000 3800 - 0x4000 3BFF	SPI2 / I2S2
	0x4000 3400 - 0x4000 37FF	I2S2ext
	0x4000 3000 - 0x4000 33FF	IWDG
	0x4000 2C00 - 0x4000 2FFF	WWDG
	0x4000 2800 - 0x4000 2BFF	RTC & BKP Registers
	0x4000 2400 - 0x4000 27FF	Reserved
	0x4000 2000 - 0x4000 23FF	TIM14
	0x4000 1C00 - 0x4000 1FFF	TIM13
	0x4000 1800 - 0x4000 1BFF	TIM12
	0x4000 1400 - 0x4000 17FF	TIM7
	0x4000 1000 - 0x4000 13FF	TIM6
	0x4000 0C00 - 0x4000 0FFF	TIM5
	0x4000 0800 - 0x4000 0BFF	TIM4
	0x4000 0400 - 0x4000 07FF	ТІМЗ
	0x4000 0000 - 0x4000 03FF	TIM2

Table 10. register boundary addresses (continued)



57



Figure 26. Typical current consumption versus temperature, Run mode, code with data processing running from Flash (ART accelerator OFF) or RAM, and peripherals OFF

# Figure 27. Typical current consumption versus temperature, Run mode, code with data processing running from Flash (ART accelerator OFF) or RAM, and peripherals ON





floating pins, they must either be configured in analog mode, or forced internally to a definite digital value. This can be done either by using pull-up/down resistors or by configuring the pins in output mode.

I/O dynamic current consumption

In addition to the internal peripheral current consumption measured previously (see *Table 28: Peripheral current consumption*), the I/Os used by an application also contribute to the current consumption. When an I/O pin switches, it uses the current from the MCU supply voltage to supply the I/O pin circuitry and to charge/discharge the capacitive load (internal or external) connected to the pin:

$$I_{SW} = V_{DD} \times f_{SW} \times C$$

where

 ${\rm I}_{\rm SW}$  is the current sunk by a switching I/O to charge/discharge the capacitive load

 $V_{DD}$  is the MCU supply voltage

 $f_{\mbox{SW}}$  is the I/O switching frequency

C is the total capacitance seen by the I/O pin: C =  $C_{INT}$ +  $C_{EXT}$ 

The test pin is configured in push-pull output mode and is toggled by software at a fixed frequency.





Figure 36. PLL output clock waveforms in down spread mode

## 5.3.12 Memory characteristics

### Flash memory

The characteristics are given at  $T_A = -40$  to 105 °C unless otherwise specified. The devices are shipped to customers with the Flash memory erased.

Symbol	Parameter	Conditions	Min	Тур	Мах	Unit
I <sub>DD</sub>		Write / Erase 8-bit mode, $V_{DD}$ = 1.8 V	-	5	-	
	Supply current	Write / Erase 16-bit mode, $V_{DD}$ = 2.1 V	-	8	-	mA
		Write / Erase 32-bit mode, $V_{DD}$ = 3.3 V	-	12	-	

 Table 39. Flash memory characteristics

Symbol	Parameter	Conditions	Min <sup>(1)</sup>	Тур	Max <sup>(1)</sup>	Unit	
t <sub>prog</sub>	Word programming time	Program/erase parallelism (PSIZE) = x 8/16/32	-	16	100 <sup>(2)</sup>	μs	
t <sub>erase16kb</sub>		Program/erase parallelism (PSIZE) = x 8	-	400	800		
	Sector (16 KB) erase time	Program/erase parallelism (PSIZE) = x 16	-	300	600	ms	
		Program/erase parallelism (PSIZE) = x 32	-	250	500		
t <sub>erase64kb</sub>		Program/erase parallelism (PSIZE) = x 8	-	1200	2400		
	Sector (64 KB) erase time	Program/erase parallelism (PSIZE) = x 16	- 700 1		1400	ms	
		Program/erase parallelism (PSIZE) = x 32	-	550	1100		

Table 40. Flash memory programming



OSPEEDRy [1:0] bit value <sup>(1)</sup>	Symbol	Parameter	Conditions	Min	Тур	Max	Unit		
			$C_L$ = 30 pF, $V_{DD}$ > 2.70 V	-	-	100 <sup>(4)</sup>			
	с	Maximum frequency <sup>(3)</sup>	C <sub>L</sub> = 30 pF, V <sub>DD &gt;</sub> 1.8 V	-	-	50 <sup>(4)</sup>			
	' max(IO)out		C <sub>L</sub> = 10 pF, V <sub>DD &gt;</sub> 2.70 V	-	-	180 <sup>(4)</sup>	IVITIZ		
			C <sub>L</sub> = 10 pF, V <sub>DD &gt;</sub> 1.8 V	-	-	100 <sup>(4)</sup>			
11		Output high to low level fall time and output low to high level rise time	C <sub>L</sub> = 30 pF, V <sub>DD &gt;</sub> 2.70 V	-	-	4			
	t <sub>f(IO)out</sub> /		C <sub>L</sub> = 30 pF, V <sub>DD &gt;</sub> 1.8 V	-	-	6	ns		
	t <sub>r(IO)out</sub>		C <sub>L</sub> = 10 pF, V <sub>DD &gt;</sub> 2.70 V	-	-	2.5			
			C <sub>L</sub> = 10 pF, V <sub>DD &gt;</sub> 1.8 V	4					
-	t <sub>EXTIpw</sub>	Pulse width of external signals detected by the EXTI controller		10	-	-	ns		

Table 50. I/O AC characteristics<sup>(1)(2)</sup> (continued)

1. Guaranteed by characterization.

 The I/O speed is configured using the OSPEEDRy[1:0] bits. Refer to the STM32F4xx reference manual for a description of the GPIOx\_SPEEDR GPIO port output speed register.

3. The maximum frequency is defined in *Figure* 37.

4. For maximum frequencies above 50 MHz, the compensation cell should be used.



#### Figure 37. I/O AC characteristics definition



Symbol	Parameter	Min	Тур	Мах	Unit	Comments
	Offset error	-	-	±10	mV	Given for the DAC in 12-bit configuration
Offset <sup>(4)</sup>	(difference between measured value at Code (0x800) and the ideal value	-	-	±3	LSB	Given for the DAC in 10-bit at V <sub>REF+</sub> = 3.6 V
	$= V_{\text{REF+}}/2)$	-	-	±12	LSB	Given for the DAC in 12-bit at V <sub>REF+</sub> = 3.6 V
Gain error <sup>(4)</sup>	Gain error	-	-	±0.5	%	Given for the DAC in 12-bit configuration
t <sub>SETTLING</sub> <sup>(4)</sup>	Settling time (full scale: for a 10-bit input code transition between the lowest and the highest input codes when DAC_OUT reaches final value ±4LSB	-	3	6	μs	$C_{LOAD} \le 50 \text{ pF},$ $R_{LOAD} \ge 5 \text{ k}\Omega$
THD <sup>(4)</sup>	Total Harmonic Distortion Buffer ON	-	-	-	dB	$\begin{array}{l} C_{LOAD} \leq 50 \text{ pF}, \\ R_{LOAD} \geq 5  k\Omega \end{array}$
Update rate <sup>(2)</sup>	Max frequency for a correct DAC_OUT change when small variation in the input code (from code i to i+1LSB)	-	-	1	MS/s	$C_{LOAD} \le 50 \text{ pF},$ $R_{LOAD} \ge 5 \text{ k}\Omega$
t <sub>WAKEUP</sub> <sup>(4)</sup>	Wakeup time from off state (Setting the ENx bit in the DAC Control register)	-	6.5	10	μs	$\label{eq:loss} \begin{array}{l} C_{LOAD} \leq 50 \text{ pF}, \ R_{LOAD} \geq 5 \ k\Omega \\ \text{input code between lowest and} \\ \text{highest possible ones.} \end{array}$
PSRR+ <sup>(2)</sup>	Power supply rejection ratio (to $V_{DDA}$ ) (static DC measurement)	-	-67	-40	dB	No R <sub>LOAD</sub> , C <sub>LOAD</sub> = 50 pF

Table 74.	DAC	characteristics	(continued)
-----------	-----	-----------------	-------------

 V<sub>DD</sub>/V<sub>DDA</sub> minimum value of 1.7 V is obtained when the device operates in reduced temperature range, and with the use of an external power supply supervisor (refer to Section : Internal reset OFF).

2. Guaranteed by design.

3. The quiescent mode corresponds to a state where the DAC maintains a stable output level to ensure that no dynamic consumption occurs.

4. Guaranteed by characterization.



mechanical data (continued)						
Symbol	millimeters			inches <sup>(1)</sup>		
	Min	Тур	Мах	Min	Тур	Мах
E3	-	7.500	-	-	0.2953	-
е	-	0.500	-	-	0.0197	-
К	0°	3.5°	7°	0°	3.5°	7°
L	0.450	0.600	0.750	0.0177	0.0236	0.0295
L1	-	1.000	-	-	0.0394	-
CCC	-	-	0.080	-	-	0.0031

# Table 92. LQFP64 – 64-pin 10 x 10 mm low-profile quad flat package mechanical data (continued)

1. Values in inches are converted from mm and rounded to 4 decimal digits.





1. Dimensions are in millimeters.





Table 95. UFBGA176+25 ball, 10 × 10 × 0.65 mm pitch, ultra thin fine pitch	
ball grid array mechanical data (continued)	

Symbol	millimeters			inches <sup>(1)</sup>		
	Min	Тур	Max	Min	Тур	Max
eee	-	-	0.150	-	-	0.0059
fff	-	-	0.050	-	-	0.0020

1. Values in inches are converted from mm and rounded to 4 decimal digits.

# Figure 88. UFBGA176+25 - 201-ball, 10 x 10 mm, 0.65 mm pitch, ultra fine pitch ball grid array recommended footprint

### Table 96. UFBGA176+2 recommended PCB design rules (0.65 mm pitch BGA)

Dimension	Recommended values
Pitch	0.65
Dpad	0.300 mm
Dsm	0.400 mm typ. (depends on the soldermask registration tolerance)

Note:

Non solder mask defined (NSMD) pads are recommended.
 4 to 6 mils solder paste screen printing process.
 Stencil opening is 0.300 mm.
 Stencil thickness is between 0.100 mm and 0.125 mm.
 Pad trace width is 0.100 mm.



# 6.6 LQFP176 package information

Figure 90. LQFP176 - 176-pin, 24 x 24 mm low profile quad flat package outline



1. Drawing is not to scale.

# Table 97. LQFP176 - 176-pin, 24 x 24 mm low profile quad flat packagemechanical data

Symbol	millimeters			inches <sup>(1)</sup>		
	Min	Тур	Мах	Min	Тур	Мах
А	-	-	1.600	-	-	0.0630
A1	0.050	-	0.150	0.0020	-	0.0059
A2	1.350	-	1.450	0.0531	-	0.0571
b	0.170	-	0.270	0.0067	-	0.0106
С	0.090	-	0.200	0.0035	-	0.0079
D	23.900	-	24.100	0.9409	-	0.9488
HD	25.900	-	26.100	1.0197	-	1.0276

DocID022152 Rev 8



meenamear data (continued)						
Symbol	millimeters			inches <sup>(1)</sup>		
	Min	Тур	Мах	Min	Тур	Max
ZD	-	1.250	-	-	0.0492	-
E	23.900	-	24.100	0.9409	-	0.9488
HE	25.900	-	26.100	1.0197	-	1.0276
ZE	-	1.250	-	-	0.0492	-
е	-	0.500	-	-	0.0197	-
L <sup>(2)</sup>	0.450	-	0.750	0.0177	-	0.0295
L1	-	1.000	-	-	0.0394	-
k	0°	-	7°	0°	-	7°
ссс	-	-	0.080	-	-	0.0031

# Table 97. LQFP176 - 176-pin, 24 x 24 mm low profile quad flat packagemechanical data (continued)

1. Values in inches are converted from mm and rounded to 4 decimal digits.

2. L dimension is measured at gauge plane at 0.25 mm above the seating plane.



Date	Revision	Changes
<b>Date</b> 04-Jun-2013	Revision 4 (continued)	Changes Updated Table 64: Dynamic characteristics: Eternity MAC signals for SMI. Updated Table 66: Dynamic characteristics: Ethernet MAC signals for MII. Updated Table 79: Synchronous multiplexed NOR/PSRAM read timings. Updated Table 80: Synchronous multiplexed PSRAM write timings. Updated Table 81: Synchronous non-multiplexed NOR/PSRAM read timings. Updated Table 82: Synchronous non-multiplexed PSRAM write timings. Updated Table 82: Synchronous non-multiplexed PSRAM write timings. Updated Section 5.3.27: Camera interface (DCMI) timing specifications including Table 87: DCMI characteristics and addition of Figure 72: DCMI timing diagram. Updated Section 5.3.28: SD/SDIO MMC card host interface (SDIO) characteristics including Table 88
		<i>characteristics</i> including <i>Table 88.</i> Updated <i>Chapter Figure 9.</i>

Table 100. Document revision history (continued)

